

Application/Control No.	Applicant(s)/Patent und Reexamination	der			
10/605,602	WANG, SUNG-FEI				
Examiner	Art Unit				
 Sing P. Chan	1734				

	SEARCHED				
Class	Subclass	Date	Examiner		
156	60, 250, 256, 267, 307.3	5/6/2005	SPC		
156	308.2	5/6/2005	SPC		
156	309.6	5/6/2005	SPC		
165	72,73,79	5/6/2005	SPC		
165	185	5/6/2005	SPC		
165	DIG515	5/6/2005	SPC		
165	80.1,80.2	5/23/2005	SPC		
165	80.3	5/23/2005	SPC		
D13	179	5/6/2005	SPC		
257	706, 707	5/6/2005	SPC		
257	704, 712	5/23/2005	SPC		
257	718, 719	5/23/2005	SPC		
361	600, 704	5/12/2005	SPC		
361	710, 717	5/23/2005	SPC		

INTERFERENCE SEARCHED						
Class	Subclass	Date	Examiner			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Text and image search on EAST	5/6/2005	SPC		
Inventor search on EAST and PALM on Wang Sung-Fei	5/6/2005	SPC		
Conferred with Dru Parries of 2836 for additional search on class 361, 165, and 256	5/9/2005	SPC		
Stic Starch	5/12/05	SPC		
Plus search	5/10/05	SPC		

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361	719-720, 707, 679, 688	5/23/2005	SPC			

INTERFERENCE SEARCHED				
Subclass	Date	Examiner		
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	Subclass	Subclass Date		

(INCLUDING SEARCH STRATEGY)						
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